

Different Approaches to Bulk Quantification



Bruker Nano Analytics, Berlin, Germany
Webinar, June 01, 2017

Na	Mg		
K	Ca	Sc	Ti
Rb	Sr	Y	Zr
Cs	Ba	La	Hf
Fr	Ra	Ac	

V	Cr	Mn	Fe	Co	Ni	Cu	Zn
Nb	Mo	Tc	Ru	Rh	Pd	Ag	Cd
Ta	W	Re	Os	Ir	Pt	Au	Hg

Ce	Pr	Nd	Pm	Sm	Eu	Gd	Tb	Dy	Ho	Er	Tm	Yb	Lu
Th	Pa	U	Np	Pu	Am	Cm	Bk	Cf	Es	Fm	Md	No	Lr



XFlash®
Technology

Micro-XRF

M4 TORNADO Webinar Outline



- Introduction

 - Presenters
 - The M4 instrument
 - Micro-XRF

- Bulk quantification

 - The basics

- Examples

 - FP Quantification: Al in Cu-alloys
 - Lucas-Tooth quantification: Au-alloys
 - Polynomial calibration: S in oil

- Live part

 - Polynomial calibration: oxidic samples

- Summary

M4 TORNADO Webinar

Presenters / Moderators



Falk Reinhardt

Application Scientist,
Bruker Nano Analytics, Berlin, Germany



Dr. Roald Tagle

Sr. Application Scientist,
Bruker Nano Analytics, Berlin, Germany

M4 Tornado micro-XRF spectrometer

Standard configuration



30 W micro-focus Rh tube with polycapillary lens

for excitation spot sizes $< 25 \mu\text{m}$ (for Mo-K α)

Option: second X-ray tube for different excitation conditions (collimated)

30 mm² silicon drift detector (SDD)

with energy resolution $< 145 \text{ eV}$ (for Mn-K α)

Option: second detector with independent SPU for double pulse throughput

Option: 60 mm² detector(s)

Sealed sample chamber

with adjustable pressure between 1 mbar and normal for detecting light elements down to Na

Sample stage with measurable area of 190 mm x 160 mm

Maximum sample height 120 mm, maximum sample weight 5 kg

Sample stage speed up to 100 mm/s, minimum step size 4 μm

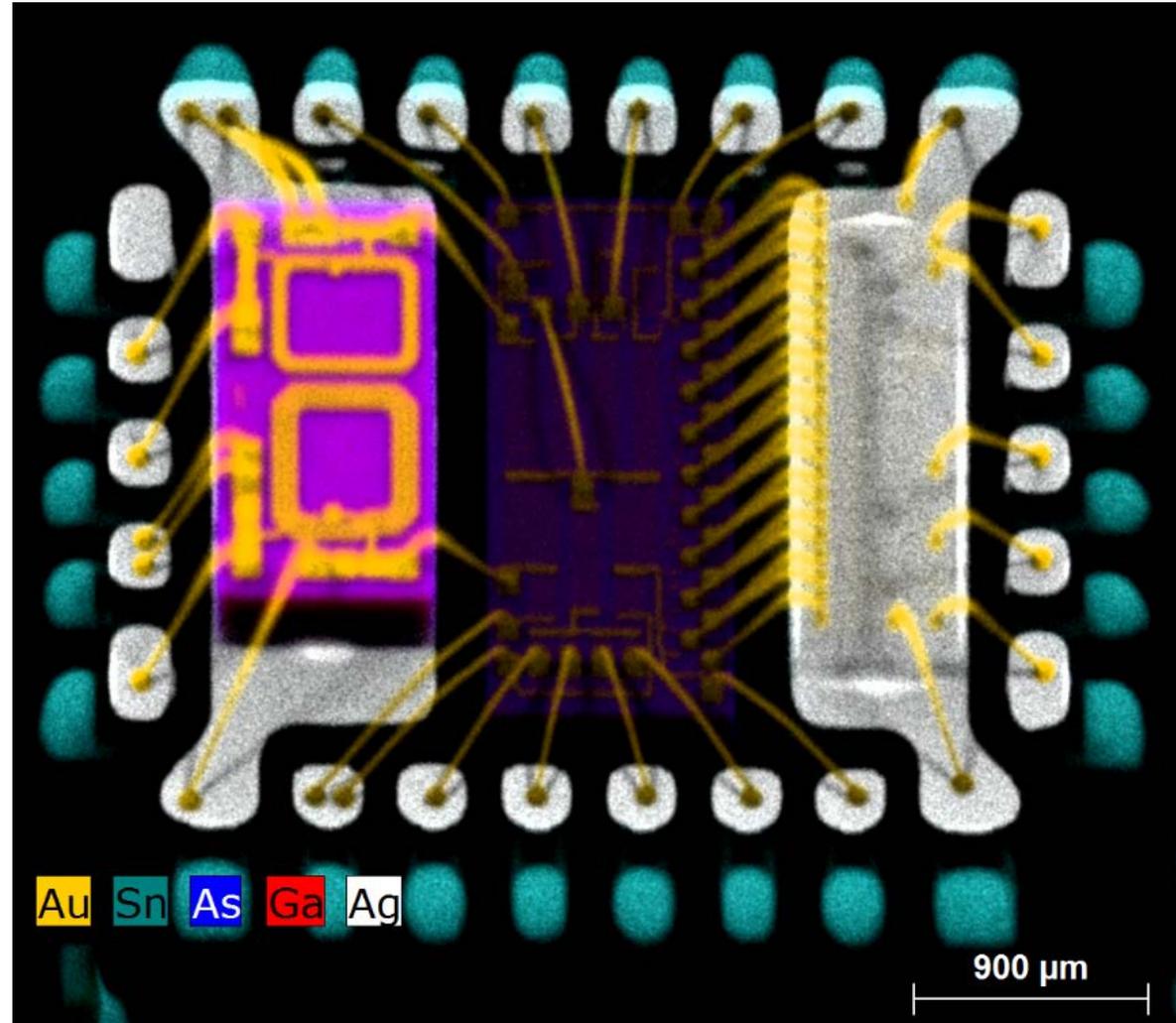
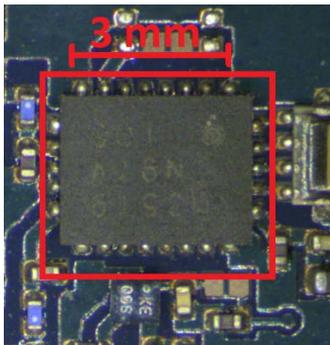


Micro-XRF features and benefits

At a glance



- Little or no sample preparation
- Non-destructive
- Elemental information
- Small spot analysis
- Information from within the sample
- Large-scale
- Quantification



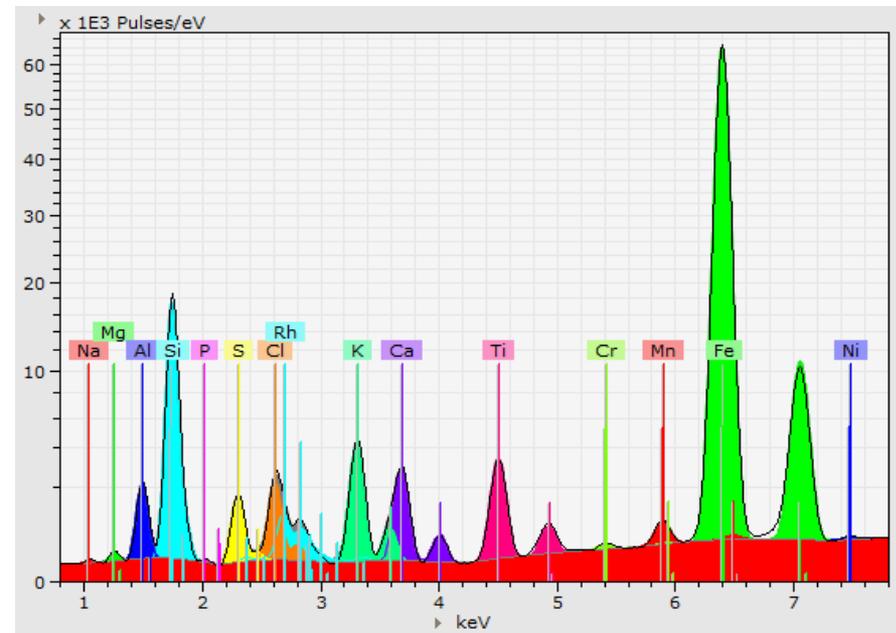
Bulk Quantification

The basics – what means quantification?



The aim is to derive the concentration of an element within a sample from the measured fluorescence signal of the respective element

This prerequisites a correlation between the concentration and the measured fluorescence intensity



Bulk Quantification

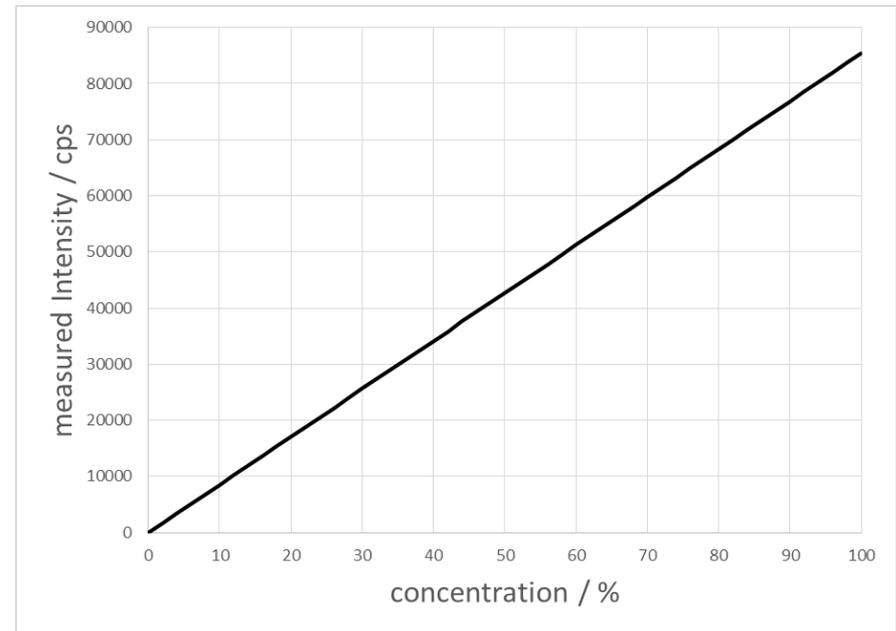
The basics – what means quantification?



The aim is to derive the concentration of an element within a sample from the measured fluorescence signal of the respective element

This prerequisites a correlation between the concentration and the fluorescence intensity

Ideally this correlation is linear



Bulk Quantification

The basics – what means quantification?



The aim is to derive the concentration of an element within a sample from the measured fluorescence signal of the respective element

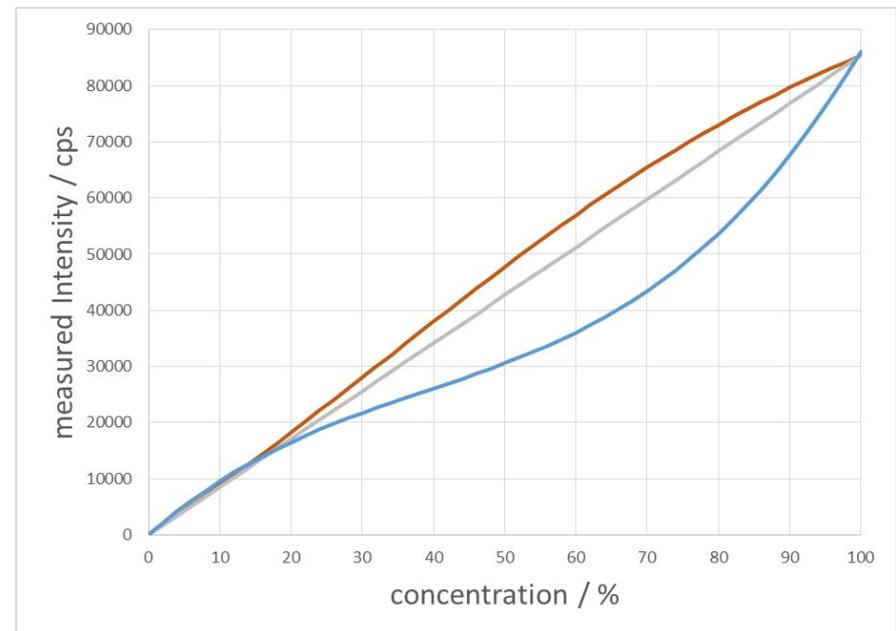
This prerequisites a correlation between the concentration and the fluorescence intensity

Ideally this correlation is linear

In reality **inter-element effects** cause deviations from perfect linearity

To correlate measured intensities to elemental concentrations **quantification models** are needed

These models can be of **different complexity** and should reflect the sample systems complexity



Bulk Quantification

The basics – quantification models



There are several ways of quantification. These can be sorted in three groups:

- Physical models (Fundamental parameter methods)
 - Calculating with **known cross sections and probabilities** of “all” physical processes taking place
 - No standards needed
 - Sample must fit the model
- Mathematical models (Empirical methods)
 - Direct correlation between measured intensities and concentrations
 - measured spectra are compared to **sufficiently similar reference spectra**
 - (many) standards needed
- Mixed models
 - Either **standard-supported FP** or FP-supported empirical methods

Bulk Quantification

The basics – quantification models



The M4 software already offers the MQuant FP routine which can be adapted to specific sample types (Type calibration)

→ see Webinar and/or Lab Report (XRF 465) on steel quantification

The XMethod software package is a tool to manage standards and additional quantification methods

- layer FP (not discussed here)
- bulk FP with multi-standard calibration (non-linear, offset)
- Lucas-Tooth (simple math, fast for multi-element samples)
- Polynomial calibration

Bulk Quantification

The basics – XMethod



METHOD EDITOR

Method data

Description

Type

Standard-based bulk (LT)
Standard-supported bulk (FP)
layer
polynomial calibration

XMethod is an add-on to the M4 software.

It provides a database for standards and method development and offers several quantification and calibration models which can be selected and adapted.

The XMethod software package allows to calibrate the quantification method if standards are available or to create non-calibrated FP methods.

Bulk Quantification

The basics – XMethod



ELEMENT PROPERTIES EDITOR

82 Pb

Parameters

Element type: Normal
Main line: LA1
Sub line: LB1
Add. sub. lines: No add. line:

start conc.: 50
Unit: ppm (0)
Calculation mode: Fixed val
Use for thickness calculation:
Threshold: 0.0005

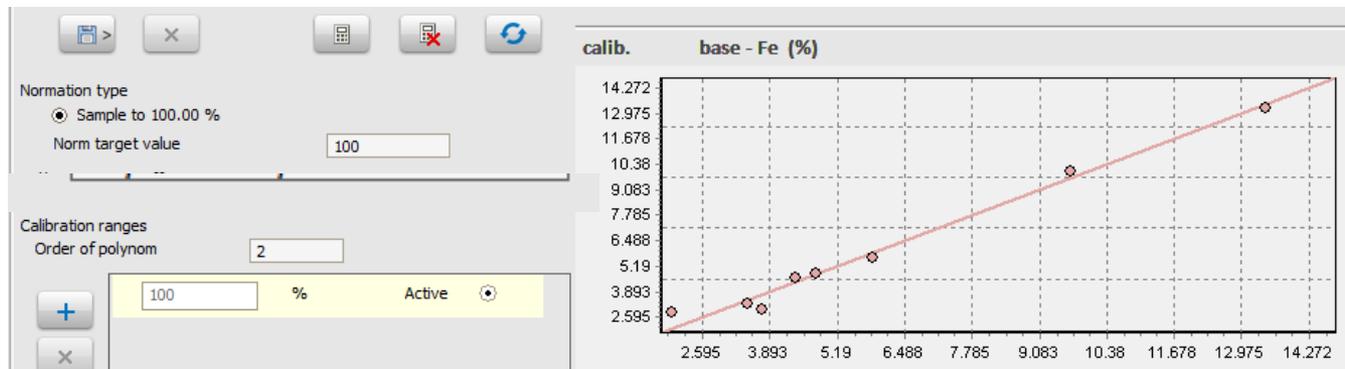
density
 Default: 11.30
 User: 1.00
 Use tolerances?

Line	Energy(keV)	Use	Used lines
LA	10.551	<input checked="" type="checkbox"/>	LA1,LA2
LB	12.614	<input checked="" type="checkbox"/>	LB3,LB4,LG2,LG3,LB1,LE,LG1,

The software provides a variety of options for optimizing methods. These options include different models for deconvolution, selection of used fluorescence (K or L-series, or even change from La to L β).

Most quantification models allow for different calibration curves for each individual element.

The created methods can be used directly in the M4 Tornado software.



Standard-supported FP

Sherman's equation



One of many ways to write down Sherman's equation:

$$I_{fl,i} = \boxed{K_i} \cdot \int_{E_{abs,i}}^{E_{max}} \int_{x=0}^D \boxed{I_0(E)} \cdot \boxed{e^{\frac{-\mu_S(E) \cdot \rho_S \cdot x}{\sin(\varphi_{in})}}} \cdot \boxed{C_i} \cdot \boxed{\tau_{i,E} \cdot Q_i(E, E_{fl})} \cdot \boxed{e^{\frac{-\mu_S(E_{fl}) \cdot \rho_S \cdot x}{\sin(\varphi_{out})}}} \cdot \boxed{\frac{\Omega}{4\pi} \cdot \varepsilon^D} dx dE$$

Excitation spectrum (as it reaches the sample)

Attenuation of excitation radiation when penetrating into the sample

Sample composition and interaction probabilities

Attenuation of fluorescence radiation when leaving the sample

Solid angle of detection and detector sensitivity

Instrument sensitivity for the respective element

Standard-supported FP Al in Cu-alloys



- Light element in heavy matrix → vastly different information depths
- Uncertainty of fundamental parameters
- Mobility of Al and Cu atoms?

Calibration samples

No.	Layer Parameter Sample	Cu(%)		Ni(%)		Fe(%)		Mn(%)		Cr(%)		Al(%)		Sn(%)		Pb(%)		Zn(%)		
		W.	Std	FP	Std	FP	Std	FP	Std	FP	Std	FP	Std	FP	Std	FP	Std	FP	Std	FP
97	82B CDA 655	1	95.30	97.54	0.01	0.02	0.08	0.18	1.04	0.84	0.00	0.04	0.00	0.68	0.02	0.06	0.01	0.01	0.38	0.63
92	77B CDA 510	1	95.20	95.80	0.00	0.01	0.00	0.08	0.00	0.00	0.05	0.00	0.42	4.66	3.40	0.02	0.01	0.01	0.01	0.24
96	81B CDA 642	1	91.20	93.22	0.00	0.01	0.05	0.13	0.01	0.00	0.00	0.04	6.70	5.94	0.01	0.13	0.01	0.14	0.18	0.39
89	72B CDA 314	1	90.08	89.83	0.00	0.01	0.01	0.10	0.00	0.00	0.06	0.00	0.56	0.03	0.07	1.99	1.39	7.81	7.99	
94	79B CDA 623	1	88.40	89.31	0.08	0.07	2.13	2.05	0.16	0.12	0.00	0.03	9.19	7.74	0.02	0.49	0.00	0.00	0.20	
98	84B CDA 706	1	87.89	87.61	10.03	9.73	1.30	1.19	0.62	0.50	0.00	0.05	0.00	0.60	0.01	0.09	0.01	0.02	0.08	0.20
93	78B CDA 544	1	87.70	89.58	0.08	0.06	0.02	0.11	0.00	0.00	0.08	0.00	0.59	4.73	3.10	3.87	2.83	3.55	3.65	
99	86C CDA 836	1	84.60	86.19	0.27	0.23	0.24	0.31	0.00	0.00	0.10	0.00	0.59	4.37	3.22	5.03	3.92	5.38	5.44	
101	91C CDA 932	1	83.20	85.65	0.46	0.43	0.03	0.11	0.00	0.00	0.07	0.00	0.40	6.77	5.39	6.80	5.19	2.62	2.76	
95	80B CDA 630	1	81.20	82.39	4.69	4.65	3.31	3.13	0.54	0.45	0.00	0.02	10.19	9.03	0.02	0.13	0.01	0.01	0.08	0.19
102	92C CDA 937	1	80.20	84.39	0.35	0.33	0.00	0.16	0.00	0.00	0.00	0.03	0.00	0.44	9.70	7.58	9.23	6.87	0.04	0.21
90	73B CDA 360	1	61.50	61.56	0.06	0.05	0.17	0.30	0.00	0.00	0.02	0.00	0.55	0.15	0.03	2.71	1.99	35.30	35.51	
100	87B CDA 857	1	60.90	60.87	0.00	0.08	0.29	0.31	0.01	0.01	0.00	0.04	0.20	0.89	0.78	0.08	1.58	1.29	36.10	36.42
91	76B CDA 485	1	60.50	60.74	0.02	0.01	0.06	0.13	0.00	0.00	0.02	0.01	0.59	0.69	0.08	1.94	1.40	36.71	37.02	
Deviation (σ)			1.79		0.10		0.10		0.11				1.10		1.00		0.99		0.21	



Normation type

Sample to 100.00 %

Norm target value

Calibration curve offset

Use offset

Calibration ranges

Order of polynomial

% Active

Calibration options:

- Deselect samples or individual values
- Normalization to 100 % y/n
- Polynomial degree
- Use offset
- Calibration ranges

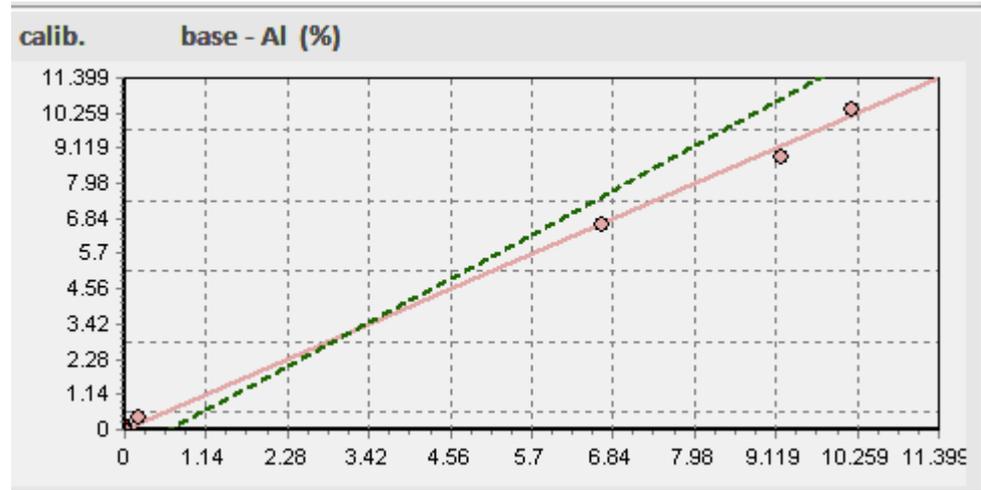
Standard-supported FP Al in Cu-alloys



- Low Al concentration expose a trend to overestimated Al values
 - Possibly surface contaminations, overestimated sensitivity?
- Higher Al concentrations are generally underestimated
 - FP values?

Calibration samples	
	Layer
	Parameter
No.	Sample
97	82B CDA 655
92	77B CDA 510
96	81B CDA 642
89	72B CDA 314
94	79B CDA 623
98	84B CDA 706
93	78B CDA 544
99	86C CDA 836
101	91C CDA 932
95	80B CDA 630
102	92C CDA 937
90	73B CDA 360
100	87B CDA 857
91	76B CDA 485
Deviation (σ)	

FP		Calib.	
Al(%)		Al(%)	
Std	FP	Std	calib.
0.00	0.68	0.00	0.11
0.00	0.42	0.00	0.00
6.70	5.94	6.70	6.66
0.00	0.56	0.00	0.00
9.19	7.74	9.19	8.84
0.00	0.60	0.00	0.02
0.00	0.59	0.00	0.01
0.00	0.59	0.00	0.00
0.00	0.40	0.00	0.00
10.19	9.03	10.19	10.36
0.00	0.44	0.00	0.00
0.00	0.55	0.00	0.00
0.20	0.89	0.20	0.37
0.01	0.59	0.01	0.00
1.10		0.21	



Linear calibration with offset
yields good results

Standard-supported FP

Al in Cu-alloys



Usually a calibration curve of 1st or 2nd order is sufficient for a wide calibration range of all selected elements

In special cases (detection limits for traces, systematic effects like described here) offset should be considered

Calibration samples

No.	Layer	Parameter	W.	Cu(%)		Ni(%)		Fe(%)		Mn(%)		Cr(%)		Al(%)		Sn(%)		Pb(%)		Zn(%)	
				Std	calib.																
97	82B CDA 655		1	95.30	98.08	0.01	0.02	0.08	0.14	1.04	0.95	0.00	0.04	0.00	0.11	0.02	0.17	0.01	0.00	0.38	0.48
92	77B CDA 510		1	95.20	95.25	0.00	0.01	0.00	0.03	0.00	0.00	0.05	0.00	0.00	4.66	4.57	0.02	0.00	0.01	0.08	
96	81B CDA 642		1	91.20	92.54	0.00	0.01	0.05	0.08	0.01	0.01	0.00	0.04	6.70	6.66	0.01	0.26	0.01	0.17	0.18	0.23
89	72B CDA 314		1	90.08	89.90	0.00	0.01	0.01	0.06	0.00	0.00	0.06	0.00	0.00	0.03	0.17	1.99	1.87	7.81	7.92	
94	79B CDA 623		1	88.40	87.99	0.08	0.07	2.13	2.17	0.16	0.14	0.00	0.03	9.19	8.84	0.02	0.72	0.00	0.01	0.04	
98	84B CDA 706		1	87.89	87.72	10.03	10.17	1.30	1.20	0.62	0.57	0.00	0.05	0.00	0.02	0.01	0.21	0.01	0.01	0.08	0.05
93	78B CDA 544		1	87.70	88.36	0.08	0.07	0.02	0.07	0.00	0.00	0.00	0.09	0.00	0.01	4.73	4.19	3.87	3.77	3.55	3.45
99	86C CDA 836		1	84.60	84.63	0.27	0.25	0.24	0.29	0.00	0.00	0.00	0.10	0.00	0.00	4.37	4.35	5.03	5.19	5.38	5.17
101	91C CDA 932		1	83.20	82.92	0.46	0.46	0.03	0.07	0.00	0.00	0.07	0.00	0.00	6.77	7.18	6.80	6.79	2.62	2.50	
95	80B CDA 630		1	81.20	80.67	4.69	4.81	3.31	3.33	0.54	0.53	0.00	0.02	10.19	10.36	0.02	0.25	0.01	0.00	0.08	0.03
102	92C CDA 937		1	80.20	80.54	0.35	0.35	0.00	0.12	0.00	0.00	0.04	0.00	0.00	9.70	10.01	9.23	8.88	0.04	0.05	
90	73B CDA 360		1	61.50	61.63	0.06	0.06	0.17	0.27	0.00	0.00	0.00	0.02	0.00	0.00	0.15	0.12	2.71	2.65	35.30	35.25
100	87B CDA 857		1	60.90	61.02	0.00	0.09	0.29	0.28	0.01	0.01	0.00	0.04	0.20	0.37	0.78	0.19	1.58	1.72	36.10	36.28
91	76B CDA 485		1	60.50	60.92	0.02	0.02	0.06	0.09	0.00	0.01	0.00	0.02	0.01	0.00	0.69	0.19	1.94	1.87	36.71	36.89
Deviation (σ)					0.91		0.06		0.06		0.04				0.21		0.38		0.14		0.11

Lucas-Tooth

fast Au quantification



Lucas-Tooth model:

$$c_i = o_i + s_i I_i + \sum_{n \neq i} (e_{ni} I_n)$$

o_i : offset for Element i

s_i : "sensitivity" for element i

I_i : measured intensity for element i

+ inter-element effects

(corrections based on intensities of other elements)

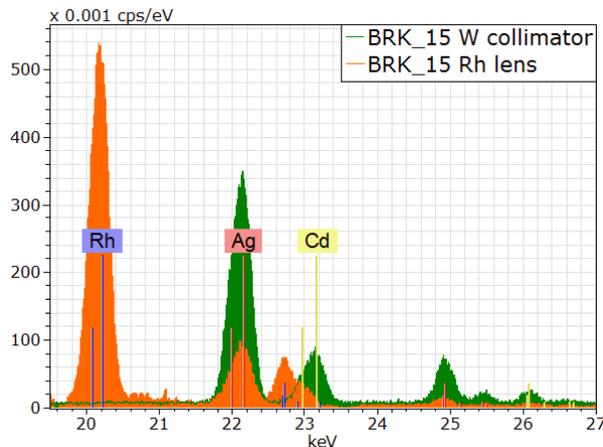
Much simpler math than FP → faster calculations

Lucas-Tooth fast Au quantification



Measurement conditions:

- W tube (no crosstalk for Ag/Cd with Rh lines)
- \varnothing 1 mm collimator (to average over inhomogeneities, high-Z efficiency)
- 50 kV / 700 μ A
- Strong 200 μ m Al + 200 μ m Ti filter (to block characteristic W lines from spectrum)
- Ambient pressure (heavy elements suffer only little from air absorption)
- 1x 30 mm² SDD
- 60 s live time



ELEMENT PROPERTIES EDITOR

⁷⁹ Au Gold

Parameters

Element type: Normal

Show element in results:

start conc.: 100,00

Unit: % (2)

Calculation mode: Calculate

Use for thickness calculation:

Threshold: 0,0005

density

Default: 19,30

User: 1,00

Use tolerances?

Line data

Line	Energy(keV)	Use	Used lines
LB	11,443	<input checked="" type="checkbox"/>	12,14,15,17,18,19,20,21,25,27,28,47,48
LA	9,713	<input checked="" type="checkbox"/>	22,24

Lucas-Tooth fast Au quantification



METHOD EDITOR
Au bulk LT LB

Structure Normation **Calibration** Spectrum

Method data

Description
Au bulk LT LB

Type
Standard-based bulk (LT)

Spectrum deconvolution
Bayes deconvolution

Comment

Measurement parameters

HV / kV 50

Collimator / mm 1.00

Atmosphere Air

Current / μ A 700

Measure time / s 20

Calibration coefficients

```
6.215077839E-2
9.441026855E-1
1.062521476E-1
1.356966132E-2
7.297788983E-2
3.11628731E-1
```

Calibration samples

No.	Layer Parameter Sample	W.	Au(%)		Ag(%)		Cu(%)		Zn(%)		Cd(%)	
			Std	calib.								
0	BRKR_01	1	99,50	99,79	0,50	0,65	0,00	0,00	0,00	0,00	0,00	0,00
1	BRKR_03	1	97,48	98,04	0,42	0,42	1,70	1,24	0,40	0,33	0,00	0,00
2	BRKR_06	1	95,42	95,50	3,45	3,59	1,13	1,21	0,00	0,00	0,00	0,00
3	BRKR_14	1	91,70	92,08	2,00	2,08	6,30	5,95	0,00	0,00	0,00	0,00
4	BRKR_15	1	91,70	91,46	2,20	2,07	5,10	5,26	0,50	0,58	0,50	0,50
5	BRKR_21	1	88,10	87,90	5,90	6,42	6,00	5,96	0,00	0,00	0,00	0,00
6	BRKR_24	1	85,05	84,60	12,20	12,29	2,20	3,19	0,00	0,00	0,55	0,55
7	BRKR_34	1	80,50	79,67	19,50	18,83	0,00	0,00	0,00	0,00	0,00	0,00
10	BRKR_47	1	72,23	71,82	18,40	17,50	4,60	7,02	3,07	3,07	1,70	1,70
11	BRKR_49	1	70,10	69,54	24,80	24,33	5,30	7,12	0,00	0,00	0,00	0,00
13	BRKR_62	1	64,50	64,97	14,90	15,55	14,90	14,67	1,90	1,89	3,80	3,80
14	BRKR_72	1	54,50	55,45	30,00	30,35	15,50	15,19	0,00	0,00	0,00	0,00
15	BRKR_75	0	49,00	49,64	25,00	27,76	26,00	23,20	0,00	0,00	0,00	0,00
16	BRKR_76	1	45,45	45,75	25,00	25,63	25,00	25,04	4,55	4,55	0,00	0,00
17	BRKR_79	1	37,50	37,14	5,00	4,57	52,50	52,61	3,00	3,00	2,00	2,00

Deviation (σ) 0,49 0,46 0,41 0,05 0,00

Normation type
 Sample to 100,00 %
 No Normation
 Norm target value 100

Calibration curve offset
 Use offset

Calibration ranges
 100 % Active

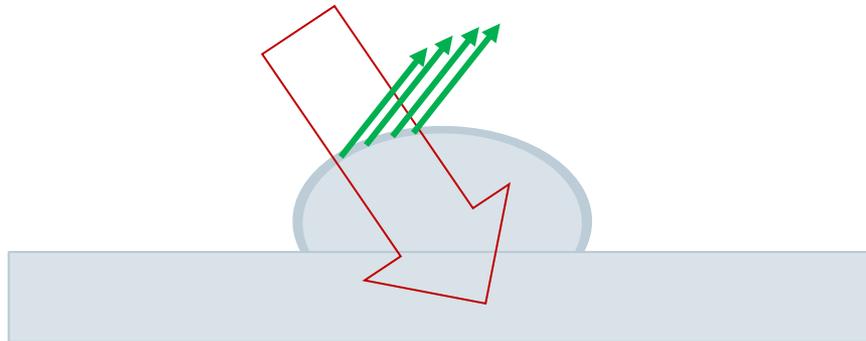
calib. base - Au (%)

Polynomial Calibration

S in oil



- Sample can hardly be described by a model (shape, density, ...)
- Very limited information depth for Sulfur
- Negligible self-absorption



Oil drop



- Simple model: concentration of S oil is linear with intensity

Polynomial Calibration

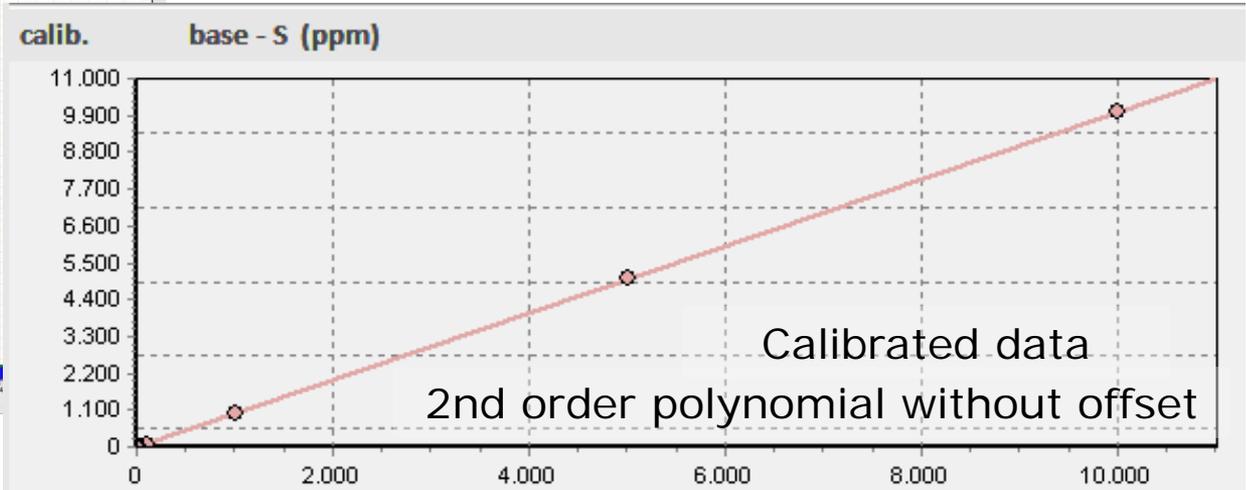
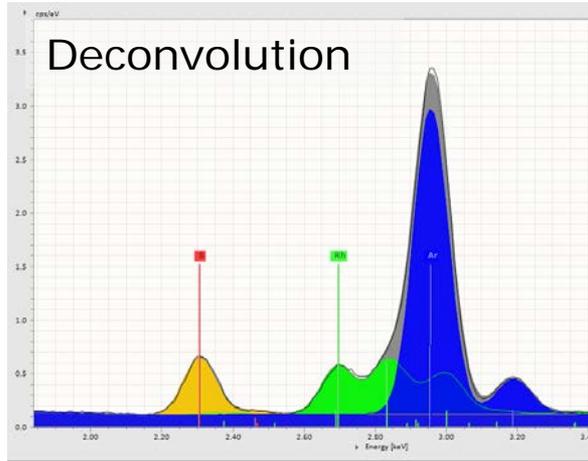
S in oil



- 10 μl of each reference sample (CONOSTAN) were deposited on a clean SiO_2 disc
- Concentration of S from 0 to 10000 ppm (1 %)
- Measurement conditions:
 - Rh tube with polycapillary lens
 - 50 kV/ 600 μA
 - No filter (Rh-L used to efficiently excite Sulfur)
 - Ambient pressure (to avoid evaporation)
 - 2x 30 mm^2 SDDs
 - 600 s real time (statistic needed especially for low concentrations)

Polynomial Calibration

S in oil



base	S	Rh	Ar
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Most simple sample description

Calibration samples

No.	Layer Parameter Sample	W.	S(ppm)		Rh(%)		Ar(%)	
			Std	calib.	Std	calib.	Std	calib.
124	S_OIL_10000 ppm	1	10000	9993	0.00	0.00	0.00	0.00
123	S_OIL_5000 ppm	1	5000	5014	0.00	0.00	0.00	0.00
122	S_OIL_1000 ppm	1	1000	995	0.00	0.00	0.00	0.00
120	S_OIL_500 ppm	0	500	458	0.00	0.00	0.00	0.00
119	S_OIL_100 ppm	1	100	93	0.00	0.00	0.00	0.00
118	S_OIL_25 ppm	1	25	23	0.00	0.00	0.00	0.00
116	S_OIL_0 ppm	1	0	6	0.00	0.00	0.00	0.00

Polynomial Calibration

Geological samples - Live



In a sample which is mostly composed of light elements (mainly Oxygen), inter-element effects, such as secondary excitation or self-absorption are no longer dominant effects.

For almost all elements with concentration $< 10\%$ the measured intensity is linear with the element's concentration.

→ Even though most geological samples can be rather complex (> 30 elements), the quantification of most elements can be performed using a simple quantification model.

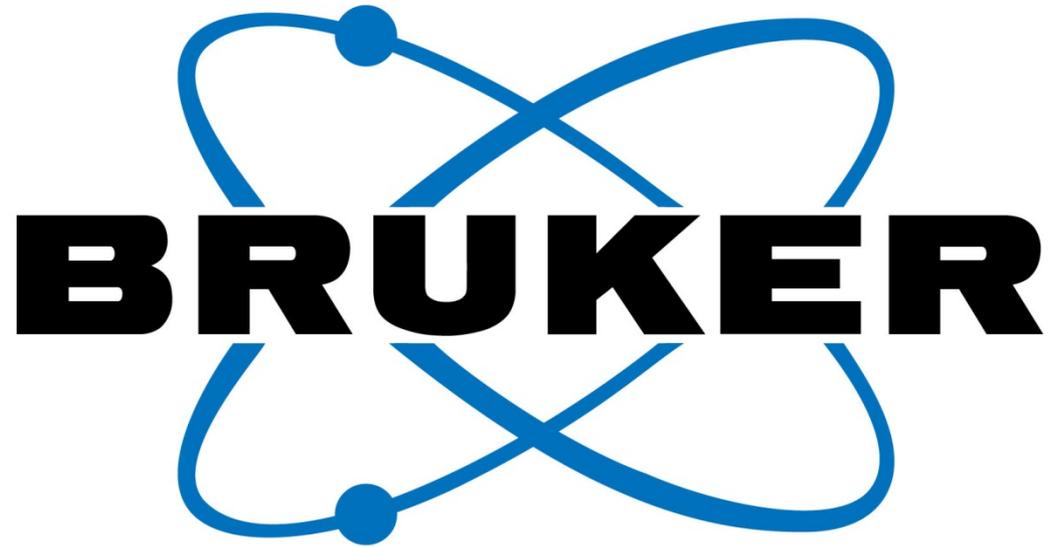
Summary



- The M4 with XMethod offers 4 different approaches to bulk quantification
- FP methods are most flexible
Calibration is an option to improve the obtained results and the standards may deviate more from the actual samples than for other approaches.
- LT method is very fast
... as it is based on simple math. A large set of very similar standards is required.
- Polynomial calibration is the most basic approach.
It is suitable when either most of the sample is not of interest (or “invisible”) and when inter-element effects can be neglected. One standard per element is sufficient but a larger number improves the calibration.

Are There Any Questions?

Please type in the questions you might have
in the Q&A box and press *Send*.



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